

STD3LN80K5

N-channel 800 V, 2.75 Ω typ., 2 A MDmesh™ K5 Power MOSFET in a DPAK package

Datasheet - production data

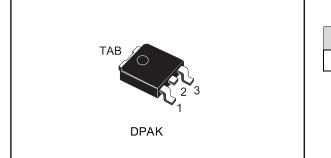
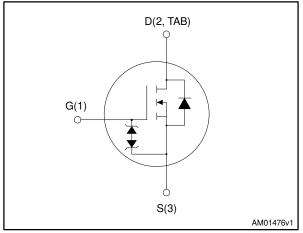


Figure 1: Internal schematic diagram



Features

Order code	V DS	R _{DS(on)} max	ID
STD3LN80K5	800 V	3.25 Ω	2 A

- Industry's lowest R_{DS(on)} x area
- Industry's best FoM (figure of merit)
- Ultra-low gate charge
- 100% avalanche tested
- Zener-protected

Applications

• Switching applications

Description

This very high voltage N-channel Power MOSFET is designed using MDmesh[™] K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

Table 1: Device summary

Order code	Marking	Package	Packing		
STD3LN80K5	3LN80K5	DPAK	Tape and reel		

This is information on a product in full production.

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1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit		
V _{GS}	Gate-source voltage	± 30	V		
ID	Drain current (continuous) at $T_C = 25 \ ^\circ C$	2	А		
lD	Drain current (continuous) at T _c = 100 °C	1.25	А		
lD ⁽¹⁾	Drain current (pulsed) 8				
P _{TOT}	Total dissipation at $T_C = 25 \text{ °C}$	45 V			
dv/dt ⁽²⁾	Peak diode recovery voltage slope	e 4.5			
dv/dt ⁽³⁾	MOSFET dv/dt ruggedness	50 V/			
T _{stg}	Storage temperature range	55 to 150	°C		
Tj	Operating junction temperature range	- 55 to 150			

Notes:

 $\ensuremath{^{(1)}}\ensuremath{\mathsf{Pulse}}$ width limited by safe operating area.

 $^{(2)}I_{SD} \leq 2$ A, di/dt ≤ 100 A/µs; V $_{DSpeak} < V_{(BR)DSS},$ V $_{DD} = 640$ V $^{(3)}V_{DS} \leq 640$ V.

Table 3: Thermal data

Symbol	Parameter	Value	Unit
Rthj-case	Thermal resistance junction-case	2.78	°C/W
Rthj-pcb ⁽¹⁾	Thermal resistance junction-pcb	50	°C/W

Notes:

 $^{(1)}When$ mounted on 1inch² FR-4 board, 2 oz Cu.

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by $T_{\text{jmax}})$	0.7	А
Eas	Single pulse avalanche energy (starting $T_j = 25^{\circ}C$, $I_D = I_{AR}$; $V_{DD} = 50 \text{ V}$)	155	mJ



2 **Electrical characteristics**

(Tc = 25 °C unless otherwise specified)

Table 5: On /off states							
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 1 \text{ mA}, V_{GS} = 0 \text{ V}$	800			V	
	Zoro gato voltago	$V_{DS} = 800 V, V_{GS} = 0 V$			1	μA	
Idss	I _{DSS} Zero gate voltage drain current	$V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V},$ $T_{C} = 125 \text{ °C}^{(1)}$			50	μA	
Igss	Gate body leakage current	$V_{GS}=\pm~20~V,~V_{GS}=0~V$			±10	μA	
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 100 \ \mu A$	3	4	5	V	
R _{DS(on)}	Static drain-source on-resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ A}$		2.75	3.25	Ω	

Notes:

⁽¹⁾Defined by design, not subject to production test.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance		-	102	-	pF
Coss	Output capacitance	V _{DS} = 100 V, f = 1 MHz, V _{GS} = 0 V	-	11	-	pF
Crss	Reverse transfer capacitance	Vd3 - V V	-	0.1	-	pF
Cotr ⁽¹⁾	Equivalent capacitance time related		-	20	-	рF
C _{oer} ⁽²⁾	Equivalent capacitance energy related	$V_{DS} = 0$ to 640 V, $V_{GS} = 0$ V	-	7	-	рF
RG	Intrinsic gate resistance	$f = 1 \text{ MHz}, I_D = 0 \text{ A}$	-	12	-	Ω
Qg	Total gate charge	$V_{DD} = 640 V, I_D = 2 A,$	-	2.63	-	nC
Qgs	Gate-source charge	V _{GS} = 10 V (see <i>Figure 15:</i> " <i>Test circuit for gate charge</i>	-	0.91	-	nC
Q_{gd}	Gate-drain charge	behavior")	-	1.53	-	nC

Table 6: Dynamic

Notes:

 $^{(1)}\mbox{Time}$ related is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

⁽²⁾Energy related is defined as a constant equivalent capacitance giving the same stored energy as Coss when VDs increases from 0 to 80% V_{DSS}



Electrical characteristics

_	Table 7: Switching times							
SymbolParameterTest conditionsMin.Typ.Max.U					Unit			
td(on)	Turn-on delay time	$V_{DD} = 400 \text{ V}, \text{ I}_{D} = 1 \text{ A}, \text{ R}_{G} = 4.7 \Omega,$	-	6.2	-	ns		
tr	Rise time	V _{GS} = 10 V (see Figure 14: "Test circuit for resistive load switching times" and Figure 19: "Switching	-	7	-	ns		
td(off)	Turn-off delay time		-	30	-	ns		
tr	Fall time	time waveform")	-	26	-	ns		

Table 8: Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		2	А
Isdm ⁽¹⁾	Source-drain current (pulsed)		-		8	А
V _{SD} ⁽²⁾	Forward on voltage	$I_{SD} = 2 \text{ A}, \text{ V}_{GS} = 0 \text{ V}$	-		1.5	V
trr	Reverse recovery time	I _{SD} = 2 A, di/dt = 100 A/μs,	-	210		ns
Qrr	Reverse recovery charge	V _{DD} = 60 V (see Figure 16: "Test circuit for inductive load	-	0.8		μC
I _{RRM}	Reverse recovery current	switching and diode recovery times")	-	7.6		А
trr	Reverse recovery time	I _{SD} = 2 A, di/dt = 100 A/μs,	-	345		ns
Qrr	Reverse recovery charge	$V_{DD} = 60 \text{ V}, \text{ T}_{\text{j}} = 150 \text{ °C}, \text{ (see Figure 16: "Test circuit for } $	-	1.2		μC
I _{RRM}	Reverse recovery current	inductive load switching and diode recovery times")	-	7.2		А

Notes:

⁽¹⁾Pulse width limited by safe operating area.

 $^{(2)}$ Pulsed: pulse duration = 300 µs, duty cycle 1.5%.

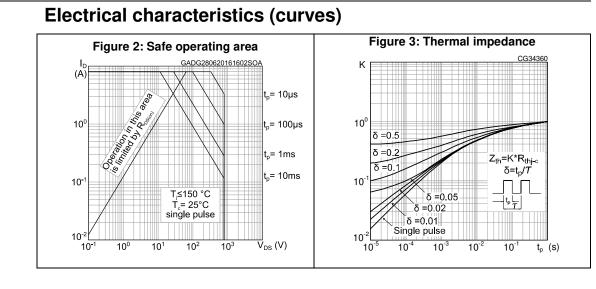
Table 9: Gate-source Zener diode

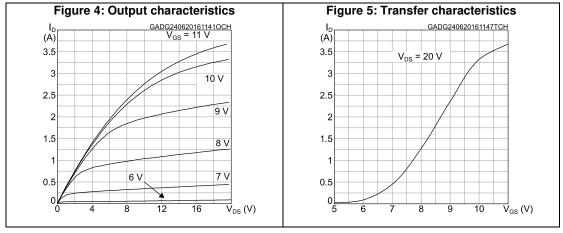
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _(BR) GSO	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{ mA}, I_D = 0 \text{ A}$	30	-	-	V

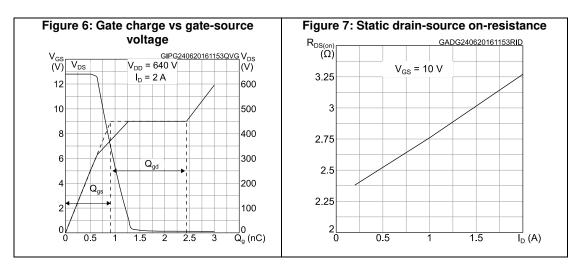
The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.



2.1



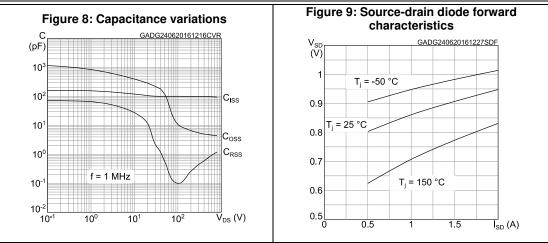


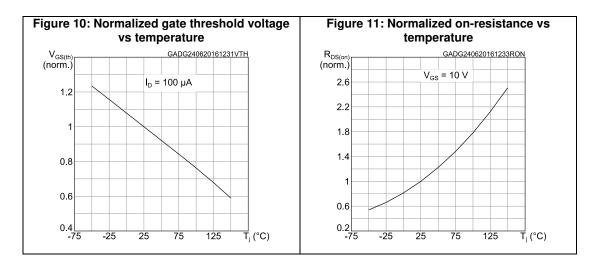


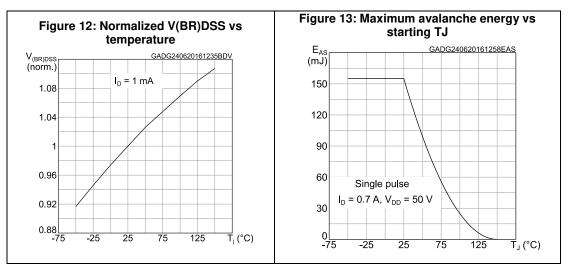


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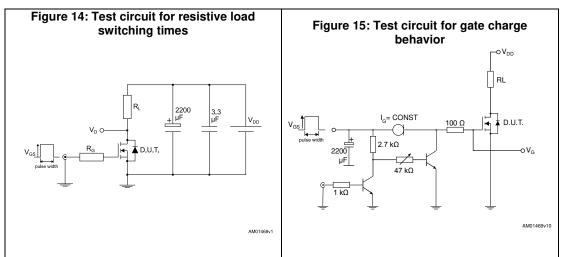
Electrical characteristics

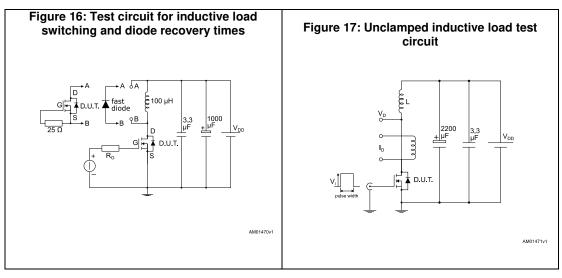


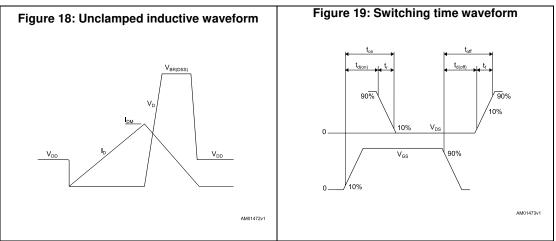




3 Test circuits







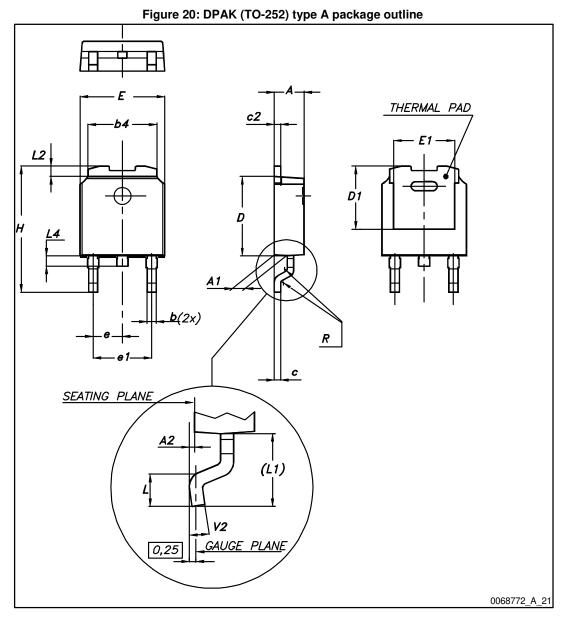


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4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.

4.1 DPAK package information



Package information

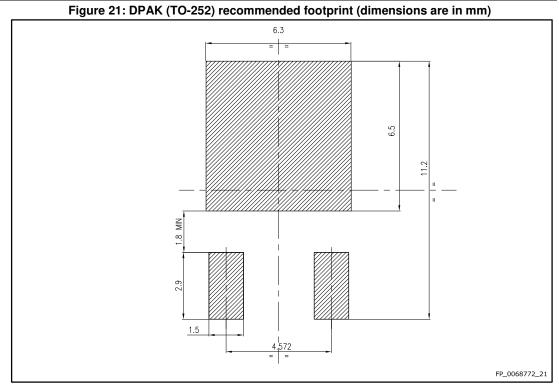
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nformation			STD3LN80K5
	Table 10: DPAK (TO-25	2) type A mechanical da	ta
Dim.		mm	
Dini.	Min.	Тур.	Max.
A	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
с	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1	4.95	5.10	5.25
E	6.40		6.60
E1	4.60	4.70	4.80
е	2.16	2.28	2.40
e1	4.40		4.60
н	9.35		10.10
L	1.00		1.50
(L1)	2.60	2.80	3.00
L2	0.65	0.80	0.95
L4	0.60		1.00
R		0.20	
V2	0°		8°



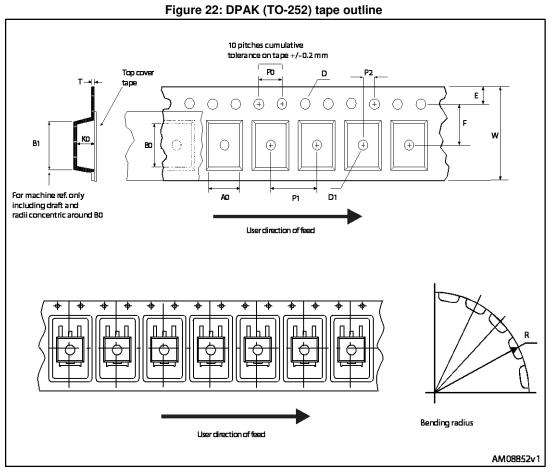
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Package information











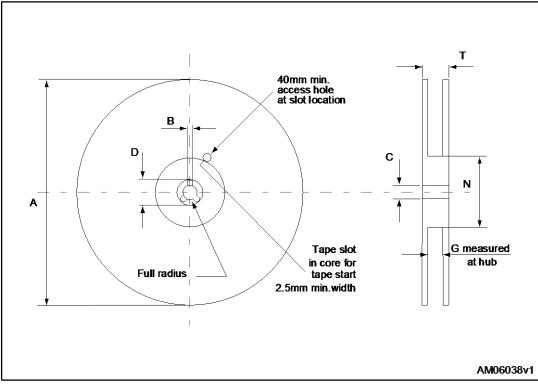


Table 11: DPAK (TO-252) tape and reel mechanical data						
Таре			Reel			
Dim.	mm		Dim	mm		
	Min.	Max.	Dim.	Min.	Max.	
A0	6.8	7	A		330	
B0	10.4	10.6	В	1.5		
B1		12.1	С	12.8	13.2	
D	1.5	1.6	D	20.2		
D1	1.5		G	16.4	18.4	
E	1.65	1.85	N	50		
F	7.4	7.6	Т		22.4	
K0	2.55	2.75				
P0	3.9	4.1	Base qty. 2500		2500	
P1	7.9	8.1	Bulk qty. 2500		2500	
P2	1.9	2.1				
R	40					
Т	0.25	0.35				
W	15.7	16.3				

Table 11: DPAK (TO-252) tape and reel mechanical data



5 Revision history

Table 12: Document revision history

Date	Revision	Changes		
13-May-2015	1	Initial release		
27-Jul-2016	2	Updated title and features in cover page. Updated Section 1: "Electrical ratings" and Section 2: "Electrical characteristics". Added Section 2.1: "Electrical characteristics (curves)". Document status promoted from preliminary to production data. Minor text changes.		



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